56	earcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/696,648	HADDAD ET AL.
Examiner	Art Unit
Raj K. Jain	2616

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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Interferen	ce search	9/19/2007	RJ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
uspgpub, uspat	4/23/2007	RJ
370/389,395.41,395.43,395.5*,441,44 2 text search.	4/14/2007	RJ
370/468,469,465,477 text search.	4/14/2007	RJ
455/9,15,16 text search	4/14/2007	RJ
inventor search	4/14/2007	RJ
370/310.2,338,328	9/19/2007	RJ